July 2008



FGH60N60SF 600V, 60A Field Stop IGBT

Features

- High current capability
- Low saturation voltage: $V_{CE(sat)} = 2.3V @ I_C = 60A$
- High input impedance •
- Fast switching •
- RoHS compliant •

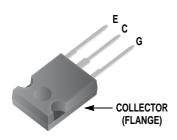
Applications

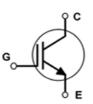
• Induction Heating, UPS, SMPS, PFC



General Description

Using Novel Field Stop IGBT Technology, Fairchild's new series of Field Stop IGBTs offer the optimum performance for Induction Heating, UPS, SMPS and PFC applications where low conduction and switching losses are essential.





Absolute Maximum Ratings

| Symbol | Description | | Ratings | Units | |
|---------------------|--|--------------------------------------|-------------|-------|--|
| V _{CES} | Collector to Emitter Voltage | | 600 | V | |
| V _{GES} | Gate to Emitter Voltage | | ± 20 | V | |
| I _C | Collector Current | @ T _C = 25 ^o C | 120 | A | |
| | Collector Current | @ T _C = 100°C | 60 | A | |
| I _{CM (1)} | Pulsed Collector Current | @ T _C = 25 ^o C | 180 | A | |
| P _D | Maximum Power Dissipation | @ T _C = 25°C | 378 | W | |
| ۰D | Maximum Power Dissipation | @ T _C = 100°C | 151 | W | |
| TJ | Operating Junction Temperature | | -55 to +150 | °C | |
| T _{stg} | Storage Temperature Range | | -55 to +150 | °C | |
| TL | Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds | | 300 | °C | |

Notes: 1: Repetitive test, Pulse width limited by max. juntion temperature

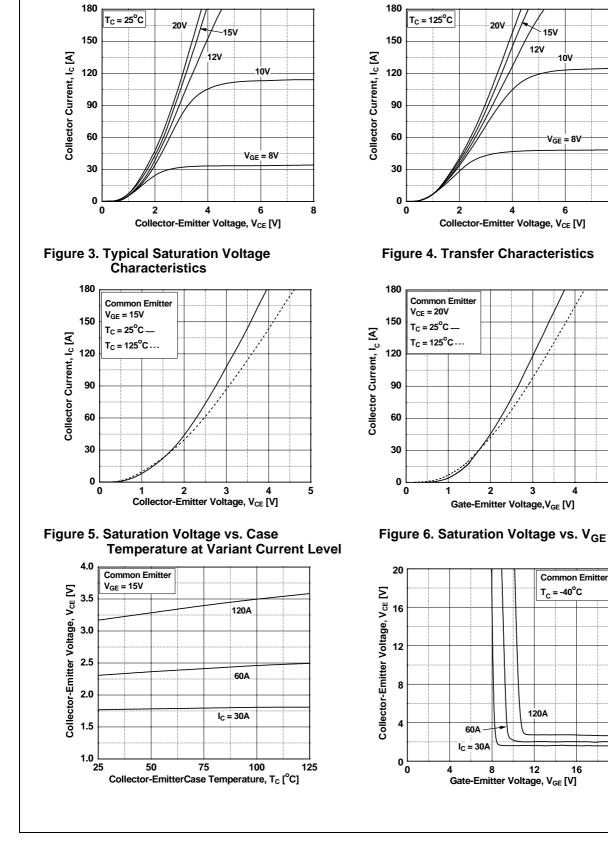
Thermal Characteristics

| Symbol | Parameter | Тур. | Max. | Units |
|------------------------|---|------|------|-------|
| $R_{\theta JC}$ (IGBT) | Thermal Resistance, Junction to Case | - | 0.33 | °C/W |
| $R_{	hetaJA}$ | Thermal Resistance, Junction to Ambient | - | 40 | °C/W |

| Symbol Off Charact BV _{CES} ΔBV_{CES} ΔT_J I _{CES} I _{GES} | 60SF al Chara eeristics Collector to Temperatu Voltage | FGH60N60SFTU acteristics of the l Parameter D Emitter Breakdown Voltage | - | Tube Tube C unless otherwise noted Conditions | | er Tube Dea Typ. | | - Box |
|---|---|---|---|--|------|------------------------|------|-------|
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| Symbol Off Charact BV _{CES} Δ BV _{CES} Δ T _J I _{CES} I _{GES} | eristics Collector to Temperatu Voltage | Parameter Demitter Breakdown Voltage | - | | Min. | Tvp. | Max | |
| Off Charact BV _{CES} ΔBV _{CES} ΔT _J I _{CES} I _{GES} | Collector to Temperatu Voltage | e Emitter Breakdown Voltage | Test (| Conditions | Min. | Tvp. | Mov | |
| BV _{CES} ΔBV _{CES} ΔT _J I _{CES} I _{GES} | Collector to Temperatu Voltage | | | | | - 71 | Max. | Units |
| ΔBV _{CES} ΔT _J I _{CES} I _{GES} | Temperatu Voltage | | | | | | | |
| ΔBV _{CES} ΔT _J I _{CES} I _{GES} | Temperatu Voltage | | | | 600 | - | - | V |
| I _{CES} I _{GES} | - | re Coefficient of Breakdown | | | - | 0.4 | - | V/ºC |
| I _{GES} | | Cut-Off Current | $V_{CE} = V_{CES}, V_{CES}$ | $V_{GE} = 0V$ | - | - | 250 | μA |
| | G-E Leaka | | $V_{GE} = V_{GES}, V_{GES}$ | | - | - | ±400 | nA |
| | | <u> </u> | 01 010 | | | | | 1 |
| On Charact V _{GE(th)} | | | I _C = 250μA, V | (\/ | 4.0 | 5.0 | 6.5 | V |
| * GE(th) | | | $I_{\rm C} = 200 \mu \text{A}, \text{ V}$ $I_{\rm C} = 60 \text{A}, \text{V}_{\rm GE}$ | | - | 2.3 | 2.9 | V |
| V _{CE(sat)} | | | $I_{C} = 60A, V_{GE} = 15V,$ $T_{C} = 125^{\circ}C$ | | - | 2.5 | - | v |
| Dynamic Cl | haracterist | ics | | | 4 | | | |
| C _{ies} | Input Capa | citance | | a) (| - | 2820 | - | pF |
| C _{oes} | Output Cap | pacitance | V _{CE} = 30V, V _{GE} = 0V, f = 1MHz | | - | 350 | - | pF |
| C _{res} | Reverse Tr | ansfer Capacitance | | | - | 140 | - | pF |
| Switching (| Characteris | tics | | | | | | |
| t _{d(on)} | Turn-On D | elay Time | | | - | 22 | - | ns |
| t _r | Rise Time | | | | - | 42 | - | ns |
| t _{d(off)} | Turn-Off D | elay Time | V _{CC} = 400V, I | I _C = 60A, | - | 134 | - | ns |
| t _f | Fall Time | | $R_G = 5\Omega$, $V_{GE} = 15V$, Inductive Load, $T_C = 25^{\circ}C$ | | - | 31 | 62 | ns |
| E _{on} | Turn-On S | witching Loss | | | - | 1.79 | - | mJ |
| E _{off} | Turn-Off Sv | witching Loss | | | - | 0.67 | - | mJ |
| E _{ts} | Total Switc | hing Loss | | | - | 2.46 | - | mJ |
| t _{d(on)} | Turn-On D | elay Time | | | - | 22 | - | ns |
| t _r | Rise Time | | | | - | 44 | - | ns |
| t _{d(off)} | Turn-Off D | elay Time | V _{CC} = 400V, I | | - | 144 | - | ns |
| t _f | Fall Time | | | $R_G = 5\Omega$, $V_{GE} = 15V$, Inductive Load, $T_C = 125^{\circ}C$ | | 43 | - | ns |
| E _{on} | Turn-On S | witching Loss | 1100011VE LUQU, 1C = 120 U | - | 1.88 | - | mJ | |
| E _{off} | | witching Loss | _ | | - | 1.0 | - | mJ |
| E _{ts} | Total Switc | hing Loss | | | - | 2.88 | - | mJ |
| Qg | Total Gate | • | | - 604 | - | 198 | - | nC |
| Q _{ge} | Gate to Em | hitter Charge | V _{CE} = 400V, I V _{GE} = 15V | C = 00A, | - | 22 | - | nC |

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Typical Performance Characteristics

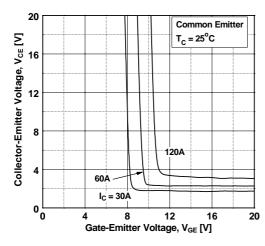
Figure 1. Typical Output Characteristics

Figure 2. Typical Output Characteristics

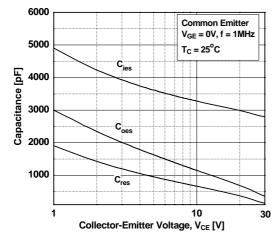
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Typical Performance Characteristics

Figure 7. Saturation Voltage vs. V_{GE}









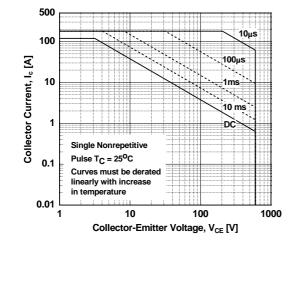


Figure 8. Saturation Voltage vs. V_{GE}

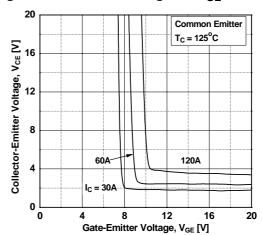


Figure 10. Gate charge Characteristics

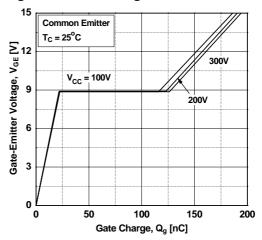
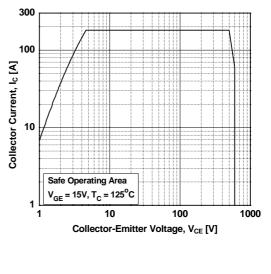
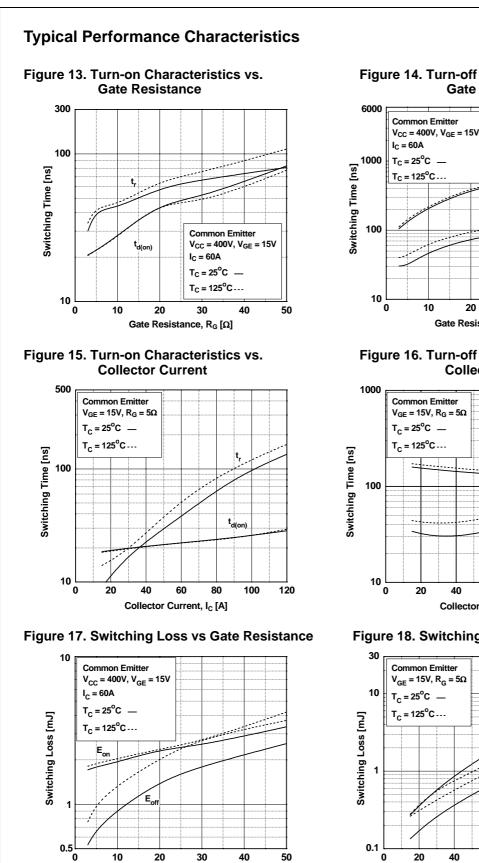
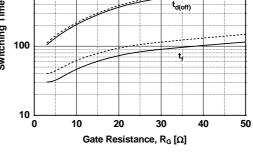


Figure 12. Turn off Switching SOA Characteristics

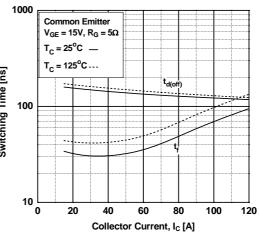












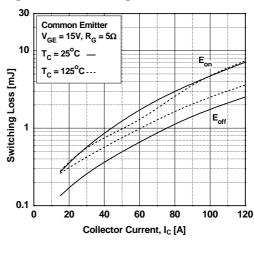


Figure 18. Switching Loss vs Collector Current

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Gate Resistance, R_G [Ω]

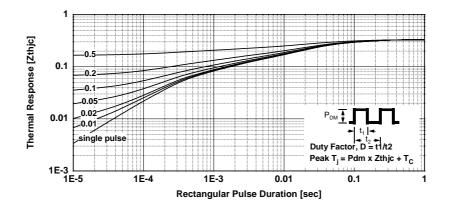
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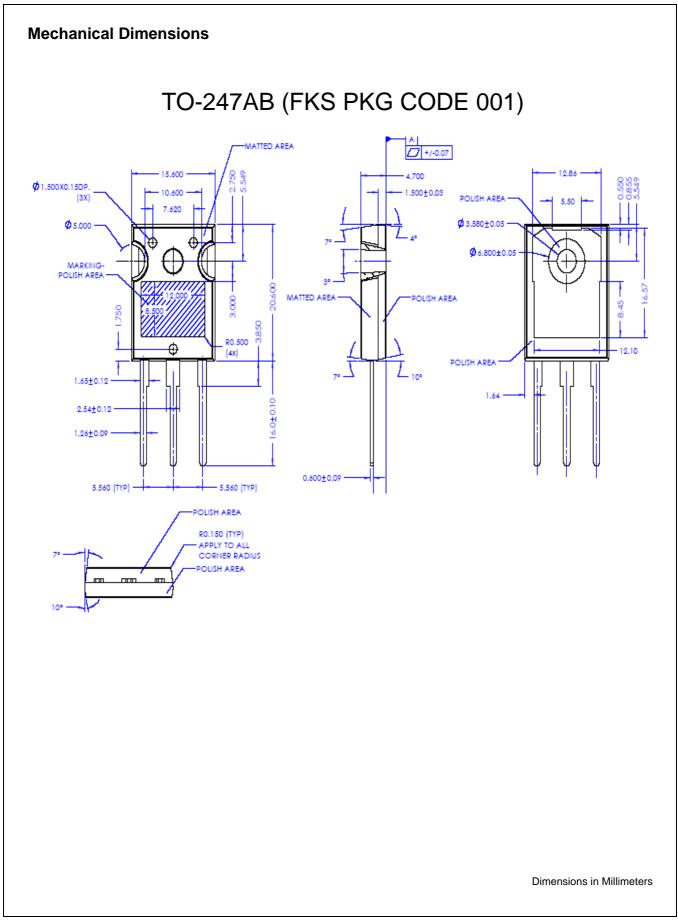
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FGH60N60SF 600V, 60A Field Stop IGBT

Typical Performance Characteristics

Figure 19. Transient Thermal Impedance of IGBT







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